TOSHIBA

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSIV)

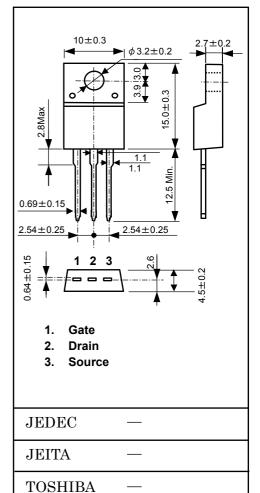
2SK3566

Switching Regulator Applications

- Low drain-source ON resistance: $RDS(ON) = 5.6 \Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 2.0 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 720 \text{ V})$
- Enhancement-mode: $V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	900	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	900	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	ID	2.5	
	Pulse (t = 1 ms) (Note 1)	I _{DP}	7.5	A
Drain power dissipation (Tc = 25° C)		PD	40	W
Single pulse avalanche energy (Note 2)		E _{AS}	216	mJ
Avalanche current		I _{AR}	2.5	А
Repetitive avalanche energy (Note 3)		E _{AR}	4	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C



Thermal Characteristics

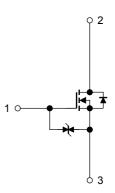
Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W	
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W	

Note 1: Please use devices on conditions that the channel temperature is below 150°C.

Note 2: $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}, \text{ L} = 63.4 \text{ mH}, \text{ I}_{AR} = 2.5 \text{ A}, \text{ R}_{G} = 25 \Omega$

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.



unit : mm

Electrical Characteristics (Ta = 25°C)

Char	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 30~V,~V_{DS}=0~V$	_		±10	μA
Gate-source breakdown voltage		V (BR) GSS	$I_D=\pm 10~\mu A,~V_{GS}=0~V$	±30			V
Drain cut-off curr	ent	I _{DSS}	$V_{DS} = 720 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			100	μA
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900			V
Gate threshold ve	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$		5.6	6.4	Ω
Forward transfer	admittance	Y _{fs}	$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 1.5 \text{ A}$	1.0	2.0		S
Input capacitance		C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		470		pF
Reverse transfer capacitance		C _{rss}			10		
Output capacitance		C _{oss}			50		
Switching time	Rise time	tr	V_{GS} $0 V$ V_{GS} $0 V$ V_{GS} $0 V$		20		
	Turn-on time	t _{on}			60	_	
	Fall time	t _f			30	_	— ns
	Turn-off time	t _{off}	Duty \leq 1%, t _w = 10 μ s		100		
Total gate charge		Qg			12		
Gate-source charge		Q _{gs}	$V_{DD}\simeq 400$ V, $V_{GS}=10$ V, $I_{D}=\!\!2.5$ A		7		nC
Gate-drain charge		Q _{gd}		_	5		

Source-Drain Ratings and Characteristics ($Ta = 25^{\circ}C$)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	2.5	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	7.5	А
Forward voltage (diode)	V _{DSF}	I_{DR} =2.5 A, V_{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 2.5 \text{ A}, V_{GS} = 0 \text{ V},$		720	—	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs	_	3.6		μC

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